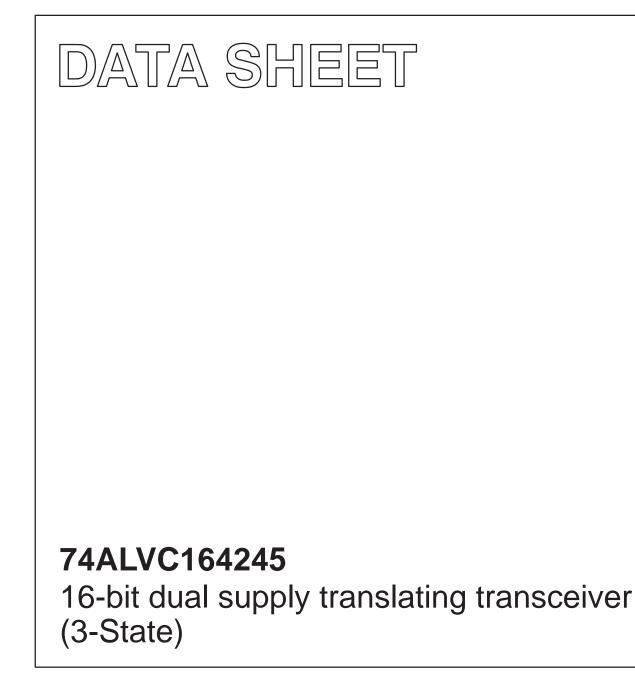
# INTEGRATED CIRCUITS



Product specification Supersedes data of 1995 Jul 01 IC24 Data Handbook

1998 Aug 26



Philips Semiconductors

## 74ALVC164245

#### **FEATURES**

- Wide supply voltage range
- A port: 1.2 to 3.6V
- B port: 1.2 to 5.5V
- Complies with JEDEC standard no. 8-1A
- Control inputs voltage range from 2.7V to 5.5V
- CMOS low power consumption
- Direct interface with TTL levels

#### DESCRIPTION

The 74ALVC164245 is a high-performance, low-power, low-voltage, Si-gate CMOS device, superior to most advanced CMOS compatible TTL families.

The 74ALVC164245 is a 16-bit (dual-octal) translating transceiver and is designed to interface between a 5V bus and 3V bus in a mixed 3V/5V supply environment. This device can be used as two 8-bit transceivers or one 16-bit transceiver. The direction control inputs (1DIR, 2DIR) determine the direction of the data flow. nDIR (active HIGH) enables data from nA ports to nB ports. nDIR (active LOW) enables data from nB ports to nA ports. The output enable inputs (1OE, 2OE), when HIGH, disable both nA and nB ports by placing them in a high impedance OFF-state. The nB ports interface with the 5V bus. The nA ports interface with the 3V bus. In suspend mode, when one of the supply voltages is zero, there will be no current flow from the non zero supply towards the zero supply.  $V_{CC1} \ge V_{CC2}$  (except in suspend mode).

## QUICK REFERENCE DATA

GND = 0V;  $T_{amb} = 25^{\circ}C$ ;  $t_r = t_f \le 2.5ns$ 

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay nA to nB nB to nA	$C_{L} = 50 \text{pF}$ $V_{CC1} = 5.0 \text{V}$ $V_{CC2} = 3.3 \text{V}$	3.7 3.1	ns
Cl	Input capacitance		5	pF
C <sub>I/O</sub>	Input/output capacitance		10	pF
C <sub>PD</sub>	Power dissipation capacitance	$V_I = GND$ to $V_{CC}^1$	20	pF

#### NOTES:

 $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ): 1.

$$\begin{split} P_{D} &= C_{PD} \times V_{CC}^{2} \times f_{i} + \Sigma \; (C_{L} \times V_{CC}^{2} \times f_{o}) \; \text{where:} \\ f_{i} &= \text{input frequency in MHz; } C_{L} &= \text{output load capacity in pF;} \end{split}$$

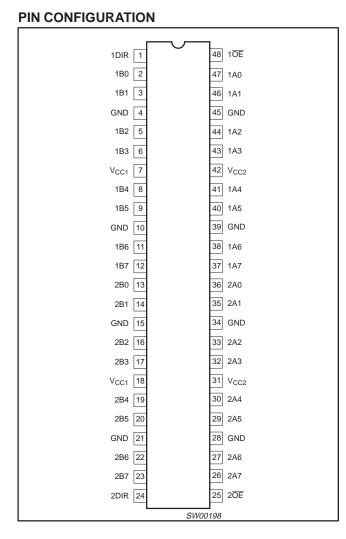
 $f_0$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;

 $\Sigma (C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$ 

## **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
48-Pin Plastic SSOP Type III	–40°C to +85°C	74ALVC164245 DL	AC164245 DL	SOT370-1
48-Pin Plastic TSSOP Type II	–40°C to +85°C	74ALVC164245 DGG	AC164245 DGG	SOT362-1

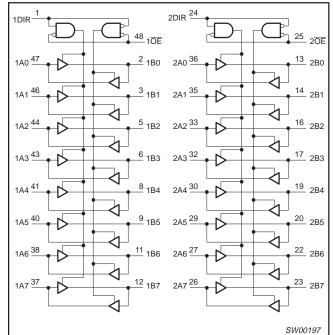
# 74ALVC164245



## **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1	1DIR	Direction control
2, 3, 5, 6, 8, 9, 11, 12	1B0 to 1B7	Data inputs/outputs
4, 10, 15, 21, 28, 34, 39, 45	GND	GND
7, 18	V <sub>CC1</sub>	Positive supply voltage (5V bus)
13, 14, 16, 17, 19, 20, 22, 23	2B0 to 2B7	Data inputs/outputs
24	2DIR	Direction control
25	2 <del>0E</del>	Output enable input (active LOW)
26, 27, 29, 30, 32, 33, 35, 36	2A7 to 2A0	Data inputs/outputs
31, 42	V <sub>CC2</sub>	Positive supply voltage (3V bus)
37, 38, 40, 41, 43, 44, 46, 47	1A7 to 1A0	Data inputs/outputs
48	1 <del>0E</del>	Output enable input (active LOW)

LOGIC SYMBOL



## **FUNCTION TABLE**

INPU	JTS	OUTPUTS		
nOE	nDIR	nAn	nBn	
L	L	A = B	inputs	
L	Н	inputs	B = A	
Н	Х	Z	Z	

= HIGH voltage level Н L = LOW voltage level

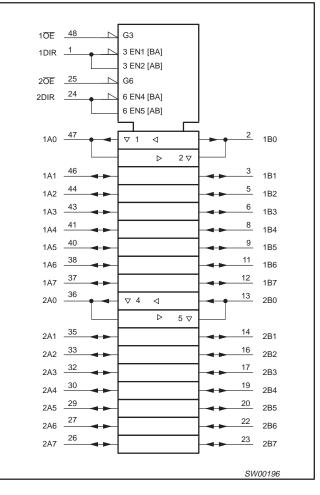
= don't care

X Z = high impedance OFF-state

#### Product specification

## 74ALVC164245

## LOGIC SYMBOL (IEEE/IEC)



## 74ALVC164245

### ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>

In accordance with the Absolute Maximum Rating System (IEC 134) Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC1</sub>	DC supply voltage (B Port)		-0.5 to +6.0	V
V <sub>CC2</sub>	DC supply voltage (A Port)		-0.5 to +4.6	V
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> <0	-50	mA
VI	DC input voltage	Note 3	-0.5 to +5.5	V
V <sub>I/O</sub>	DC input voltage range for I/Os		–0.5 to V <sub>CC</sub> +0.5	V
I <sub>OK</sub>	DC output diode current	$V_{O} > V_{CC} \text{ or } V_{O} < 0$	±50	mA
V <sub>O</sub>	DC output voltage	Note 3	–0.5 to V <sub>CC</sub> +0.5	V
Ι <sub>Ο</sub>	DC output source or sink current	$V_{O} = 0$ to $V_{CC}$	±50	mA
I <sub>GND</sub> , I <sub>CC</sub>	DC V <sub>CC</sub> or GND current		± 100	mA
T <sub>stg</sub>	Storage temperature range		-60 to +150	°C
P <sub>TOT</sub>	Power dissipation per package -plastic medium-shrink SO (SSOP) -plastic mini-pack (TSSOP)	For temperature range: -40 to +125 °C above +55°C derate linearly with 11.3 mW/K above +55°C derate linearly with 8 mW/K	850 600	mW

#### NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
The input and output upters reliance may be exceeded if the input and output extract reliance may be exceeded if the input and output extract reliance may be exceeded if the input and output extract reliance may be exceeded if the input and output extract reliance may be exceeded if the input and extract reliance may be exceeded if the input and extract reliance may be exceeded.

3. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

## **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	CONDITIONS	LIM	UNIT	
STWBUL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V <sub>CC1</sub>	DC supply voltage (for max. speed performance) (B Port)	$V_{CC1} \ge V_{CC2}$	2.7	5.5	V
V <sub>CC2</sub>	DC supply voltage (for max. speed performance) (A Port)	$V_{CC1} \ge V_{CC2}$	2.7	3.6	V
V <sub>CC1</sub>	DC supply voltage (for low-voltage applications) (B Port)	$V_{CC1} \ge V_{CC2}$	1.5	5.5	V
V <sub>CC2</sub>	DC supply voltage (for low-voltage applications) (A Port)	$V_{CC1} \ge V_{CC2}$	1.5	3.6	V
VI	DC Input voltage range		0	5.5	V
V <sub>I/O</sub>	DC Input voltage range for I/Os	A Port	0	V <sub>CC2</sub>	V
V <sub>I/O</sub>	DC Output voltage range for I/Os	B Port	0	V <sub>CC1</sub>	V
V <sub>0</sub>	DC Output voltage range	A Port	0	V <sub>CC2</sub>	V
V <sub>0</sub>	DC Output voltage range	B Port	0	V <sub>CC1</sub>	V
T <sub>amb</sub>	Operating free-air temperature range		-40	+85	°C
t <sub>r</sub> , t <sub>f</sub>	Input rise and fall times	$\begin{array}{l} V_{CC2} = 2.7 \ to \ 3.0V \\ V_{CC2} = 3.0 \ to \ 3.6V \\ V_{CC1} = 3.0 \ to \ 4.5V \\ V_{CC1} = 4.5 \ to \ 5.5V \end{array}$	0 0 0 0	20 10 20 10	ns/V

## DC ELECTRICAL CHARACTERISTICS

				L			
SYMBOL	PARAMETER	TEST CONDITIO	TEST CONDITIONS		Temp = -40°C to +85°C		
					TYP <sup>1</sup>	MAX	1
N/	HIGH level Input voltage (B Port)	V <sub>CC</sub> = 4.5 to 5.5V (Note 2)		2.0			V
VIH	HIGH level Input voltage (A Port)	V <sub>CC</sub> = 2.7 to 3.6V (Note 2)		2.0			ľ
Ma	LOW level Input voltage (B Port)	V <sub>CC</sub> = 4.5 to 5.5V (Note 2)				0.8	v
VIL	LOW level Input voltage (A Port)	V <sub>CC</sub> = 2.7 to 3.6V (Note 2)				0.8	
		$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $I_{O}$ =	–100μA	V <sub>CC</sub> -0.2	V <sub>CC</sub>		
	HIGH level output voltage (B Port)	$V_{CC}$ = 4.5V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ =	–24mA	V <sub>CC</sub> -0.8			]
V <sub>OH</sub>		$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $I_{O}$ =	–12mA	V <sub>CC</sub> -0.5			] _
VOH		$V_{CC} = 3.0V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O =$	–100μA	V <sub>CC</sub> -0.2			
	HIGH level output voltage (A Port)	$V_{CC}$ = 3.0V; $V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $I_{O}$ =	V <sub>CC</sub> -1.0				
		$V_{CC}$ = 2.7V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ =	V <sub>CC</sub> -0.6	V <sub>CC</sub>		1	
		$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $I_{O}$ =	100µA			0.20	
	LOW level output voltage (B Port)	$V_{CC}$ = 4.5V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ =			0.55	- V	
V <sub>OL</sub>		$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $I_{O}$ =			0.40		
VOL		$V_{CC}$ = 3.0V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu$ A					0.20
	LOW level output voltage (A Port)	$V_{CC}$ = 3.0V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ =			0.55		
		$V_{CC}$ = 2.7V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 12mA					0.40
ł	Input leakage current	$V_{CC}$ = 3.6V; $V_{I}$ = 5.5V or GND	Control pins		±0.1	±5	μΑ
I <sub>IHZ</sub> /I <sub>II Z</sub>	Input current for common I/O pins (B Port)	$V_{CC}$ = 5.5V; $V_{I}$ = $V_{CC}$ or GND			±0.1	±15	
'IHZ''ILZ	Input current for common I/O pins (A Port)	$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } GND$	$V_{CC} = 3.6V; V_I = V_{CC} \text{ or GND}$		±0.1	±15	- μA
laa	Quiescent supply current (B Port)	$V_{CC} = 5.5V$ ; $V_I = V_{CC}$ or GND; $I_O = 0$			0.2	40	μA
Icc	Quiescent supply current (A Port)	$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } \text{GND}; I_O = 0$			0.2	40	
Δlcc	Additional quiescent supply current per input pin (B Port)	$V_{CC} = 4.5V$ to 5.5V; $V_{I} = V_{CC} - C$	0.6V; I <sub>O</sub> = 0		5	500	μΑ
	Additional quiescent supply current per control pin (A Port)	$V_{CC} = 2.7V$ to 3.6V; $V_{I} = V_{CC} - C$	0.6V; I <sub>O</sub> = 0		5	500	

**NOTES:** 1. All typical values are at  $V_{CC1} = 5.0V$ ,  $V_{CC2} = 3.3V$  and  $T_{amb} = 25^{\circ}C$ . 2. If  $V_{CC2} < 2.7V$ , the switching levels at all inputs are not TTL compatible.

## 74ALVC164245

## 74ALVC164245

#### **AC CHARACTERISTICS**

GND = 0V;  $t_R = t_F = 2.5ns$ ;  $C_L = 50pF$ ;  $R_L = 500\Omega$ ;  $T_{amb} = -40^{\circ}C$  to +85°C.

				LIM	ITS		
SYMBOL	PARAMETER	WAVEFORM	V <sub>CC1</sub> = 5. V <sub>CC2</sub> = 3.	0V ±0.5V 3V ±0.3V	V <sub>CC1</sub> = 5. V <sub>CC2</sub> =	0V ±0.5V = 2.7V	UNIT
			MIN	MAX	MIN	MAX	
t <sub>PHL</sub> t <sub>PLH</sub>	Propagation delay nAn to nBn	1	1	5.8		5.9	ns
t <sub>PHL</sub> t <sub>PLH</sub>	Propagation delay nBn to nAn	1	1.2	5.8		6.7	ns
t <sub>PZH</sub> t <sub>PZL</sub>	3-State output enable time nOE to nAn	2	1	8.9		9.3	ns
t <sub>PZH</sub> t <sub>PZL</sub>	3-State output enable time nOE to nBn	2	2.1	9.5		9.2	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	3-State output disable time	2	2	9.1		10.2	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	3-State output disable time	2	2.9	8.6		9	ns

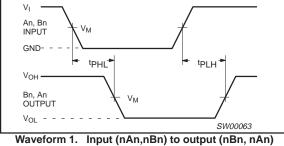
NOTE:

1. All typical values are at V\_{CC1} = 5.0V, V\_{CC2} = 3.3V and T\_{amb} = 25°C.

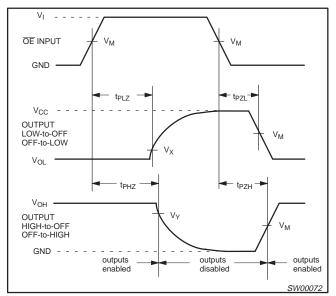
2. All typical values are at  $V_{CC1} = 5.0V$ ,  $V_{CC2} = 2.7V$  and  $T_{amb} = 25^{\circ}C$ .

### AC WAVEFORMS

 $\begin{array}{l} V_{M} = 1.5V \; at \; V_{CC} \leq 3.6V \\ V_{M} = 0.5 \; * \; V_{CC1} \; at \; V_{CC1} \geq 4.5V. \\ V_{X} = V_{OL} + 0.3V \; at \; V_{CC} \leq 3.6V \\ V_{X} = V_{OL} + 0.1 \; * (V_{OH} - V_{OL}) \; at \; V_{CC1} \geq 4.5V \\ V_{Y} = V_{OH} - 0.3V \; at \; V_{CC} \leq 3.6V \\ V_{Y} = V_{OH} - 0.1 \; * (V_{OH} - V_{OL}) \; at \; V_{CC1} \geq 4.5V \\ V_{OL} \; and \; V_{OH} \; are \; the \; typical \; output \; voltage \; drops \\ that \; occur \; with \; the \; output \; load. \end{array}$ 

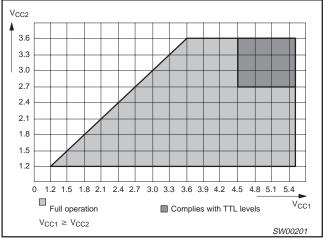


propagation delays

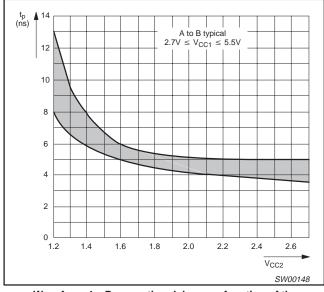


Waveform 2. 3-State enable and disable times

# 74ALVC164245

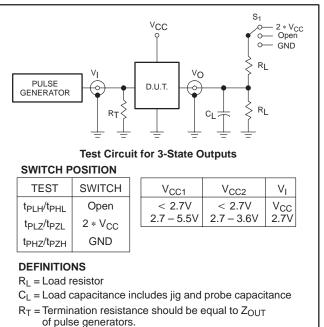


Waveform 3. Supply operating area



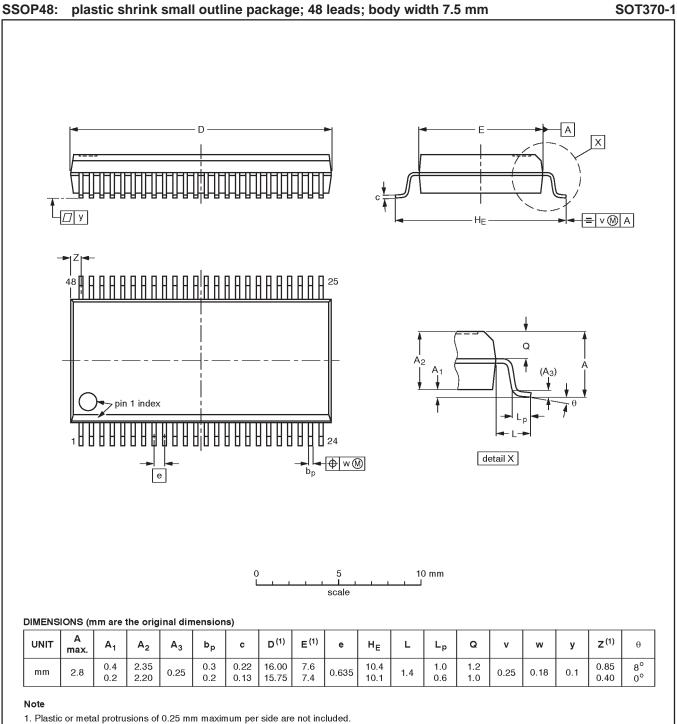
Waveform 4. Propagation delay as a function of the supply voltage, V<sub>CC2</sub>

**TEST CIRCUIT** 



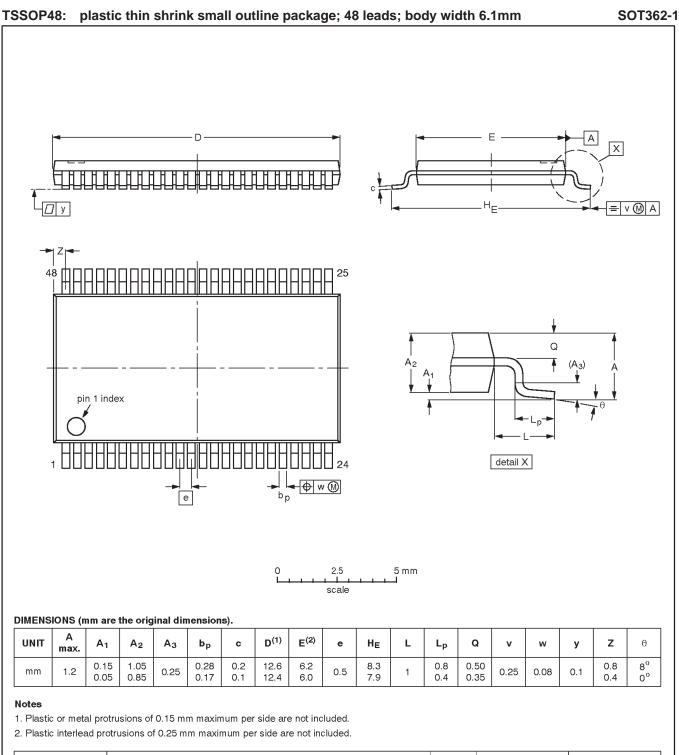
Waveform 5. Load circuitry for switching times

## 74ALVCH164245



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUEDATE
SOT370-1		MO-118AA				<del>-93-11-02</del> 95-02-04

## 74ALVCH164245



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	
SOT362-1		MO-153ED				<del>- 93-02-03-</del> 95-02-10

# 74ALVCH164245

NOTES

## 74ALVCH164245

	DEFINITIONS				
Data Sheet Identification Product Status Definition		Definition			
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.			
Preliminary Specification	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.			
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